SERIAL NO.	CASE NO.
10/036,067	10630/9
FILING DATE	GROUP ART UNIT
October 19, 2001	
APPLICANT(S): Madocks	
	10/036,067 FILING DATE October 19, 2001

XAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
12-	A1	2,146,025	02/07/1939	F. M. Penning	104	192./2
19	A2	3,884,793	05/20/1975	Penfold et al.	204	29816
	A3	4,126,530	11/21/1978	Thornton	204	R2.3
	A4	4,166,018	08/28/1979	Chapin	204	Ad.12
	A5	4,277,304	07/07/1981	Horiike et al.	438	74
	A6	4,336,277	06/22/1982	Bunshah et al.	427	561
	A7	4,356,073	10/26/1982	McKelvey	204	H2.12
	A8	4,361,472	11/30/1982	Morrison, Jr.	204	192.12
	A9	4,407,894	10/04/1983	Kadokura et al.	428	457
	A10	4,422,896	12/27/1983	Class et al.	216	67
	A11	4,434,038	02/28/1984	Morrison, Jr.	201	192.1
	A12	4,576,700	03/18/1986	Kadokura et al.	204	42.1
	A13	4,767,516	08/30/1988	Nakatsuka et al.	204	192.19
	A14	4,784,739	11/15/1988	Kadokura et al.		192.0
	A15	4,842,708	06/27/1989	Kadokura et al.	201850	288.10
	A16	4,863,756	09/05/1989	Hartig et al.	イガナーク	11 H88
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	A18	4,963,524	10/16/1990	Yamazaki	725 62	406
	A19	5,000,834	03/19/1991	Yoshikawa	234,	22808 22808
	A20	5,022,978	06/11/1991	Hensel et al.	/47//	~~~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~
1	A21	5,135,819	08/04/1992	Ito et al.	428 UN	694RE
	A22	5,196,105	03/23/1993	Feuerstein et al.	204	298.19
	A23	5,328,583	07/12/1994	Kameyamma et al.	204	192.12
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	A25	5,556,519	09/17/1996	Teer	204	192.12
	A26	5,635,087	06/03/1997	Schiller et al.	ચાવ	121.43
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	A28	5,945,008	08/31/1999	Kisakibaru et al.	216	71
	A29	5,973,447	10/26/1999	Mahoney et al.	8/3	359.1
	A30	6,130,002	10/10/2000	Neumann et al.	428	688
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EXAMINER INITIAL DOCUMENT NUMBER DATE COUNTRY SUBCLASS YES NO

DATE CONSIDERED 1/26/3

Rick et al.

02/13/2001

EXAMINER: Initial of reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO-1449		SERIAL NO.	CASE NO.
	FEB 0 7 2002 -	10/036,067	10630/9
LIST OF PAT	ENTS AND PUBLICATIONS FOR	FILING DATE	GROUP ART UNIT
	S NFORMATION DISCLOSURE	October 19, 2001	
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(use several sheets	if necessary)	APPLICANT(S): Madocks	

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES NO	

EXAMINER INITIAL		OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)
BZ-	A33	Musil et al., "Unbalanced magnetrons and new sputtering systems with enhanced plasma ionization", <i>J. Vac. Sci. Tehnol.</i> , A, vol. 9, No. 3, pp. 1171-1177, May/June 1991.
The	A34	J. Reece Roth, "Industrial Plasma Engineering", vo1. 1, pp. © IOP Publishing Ltd. 1995 pp. 334-337.

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EXAMINER DATE CONSIDERED 1/23/03

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FORM PTO-1449	SERIAL NO. 10/036,067	CASE NO. 10630/9
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT	FILING DATE October 19, 2001	GROUP ART UNIT 1746
(up coveral sheets if necessary)	APPLICANT(S): Madocks	

REFERENCE	DESIG	NATION	U.S. PATE	NT DOCUMENTS		
EXAMINER		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
INITIAL	Δ1	5,627,435	5/6/97	Jansen et al.	315	111.21

	FC	REIGN PATE	NT DOCUMENTS	T 31 4004	TOANO	ATION
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS/ SUBCLASS	YES	NO_
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EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

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